imall

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HEXFET[®] Power MOSFET

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature,

fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

Bass part number	Dookogo Tupo	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
	D Dak	Tube	75	AUIRFR4620
AUIRFR4620	D-Pak	Tape and Reel Left	3000	AUIRFR4620TRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	24	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	17	А
I _{DM}	Pulsed Drain Current ①	100	
P _D @T _C = 25°C	Maximum Power Dissipation	144	W
	Linear Derating Factor	0.96	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 2	113	mJ
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	А
E _{AR}	Repetitive Avalanche Energy ①		mJ
dv/dt	Pead Diode Recovery dv/dt③	54	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case ®		1.045	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ heta JA}$	Junction-to-Ambient 🗇		110	

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com

R _{DS(on)}	typ.	64mΩ
	max.	78mΩ
D		24A



G	D	S
Gate	Drain	Source



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	200			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.23		V/°C	Reference to 25°C, $I_D = 5mA \oplus$
R _{DS(on)}	Static Drain-to-Source On-Resistance		64	78	mΩ	V _{GS} = 10V, I _D = 15A ④
V _{GS(th)}	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$
gfs	Forward Trans conductance	37			S	V _{DS} = 50V, I _D = 15A
	Internal Gate Resistance		2.6		Ω	
1	Drain-to-Source Leakage Current			20	μA	V _{DS} = 200V, V _{GS} = 0V
I _{DSS}				250	μΑ	V _{DS} = 200V,V _{GS} = 0V,T _J =125°C
	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			100	n۸	V _{GS} = 20V
I _{GSS}				-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

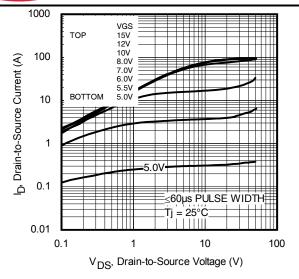
	<u> </u>		'		
Q _g	Total Gate Charge	 25	38		I _D = 15A
Q_{gs}	Gate-to-Source Charge	 8.2		nC	V _{DS} = 100V
Q _{gd}	Gate-to-Drain Charge	 7.9			V _{GS} = 10V④
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})	 17			
t _{d(on)}	Turn-On Delay Time	 13.4			V _{DD} = 130V
t _r	Rise Time	 22.4			I _D = 15A
t _{d(off)}	Turn-Off Delay Time	 25.4		ns	R _G = 7.3Ω
t _f	Fall Time	 14.8			V _{GS} = 10V④
C _{iss}	Input Capacitance	 1710			V _{GS} = 0V
C _{oss}	Output Capacitance	 125			V _{DS} = 50V
C _{rss}	Reverse Transfer Capacitance	 30		pF	f = 1.0MHz
C _{oss eff.} (ER)	Effective Output Capacitance (Energy Related)	 113			$V_{GS} = 0V, V_{DS} = 0V$ to 160V (6)
C _{oss eff.} (TR)	Effective Output Capacitance (Time Related)	 317			$V_{GS} = 0V, V_{DS} = 0V$ to 160V (5)
Diode Chara	cteristics				

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			24		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			100		integral reverse
V_{SD}	Diode Forward Voltage		_	1.3	V	T _J = 25°C,I _S = 15A,V _{GS} = 0V ④
t _{rr}	Reverse Recovery Time		78			T _J = 25°C
			99		ns	$T_{\rm J} = 125^{\circ}C$ $V_{\rm R} = 100V$,
Q _{rr}	Reverse Recovery Charge		294		nC	$T_{\rm J} = 25^{\circ}C$ $I_{\rm F} = 15A$
			432		nc	T _J = 125°C di/dt = 100A/µs ④
			7.6		Α	T _J = 25°C
t _{on}	Forward Turn-On Time	Intrinsic	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- $\[\]$ Limited by T_{Jmax}, starting T_J = 25°C, L = 1.0mH, R_G = 25 Ω , I_{AS} = 15A, V_{GS} =10V. Part not recommended for use above this value.
- $\label{eq:ISD} \textcircled{3} \quad I_{SD} \leq 15A, \ di/dt \leq 634A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^\circ C.$
- ④ Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- \odot C_{oss eff}. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- 6 C_{oss eff.} (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- \circledast R₀ is measured at T_J approximately 90°C.







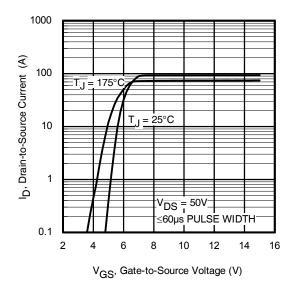


Fig. 3 Typical Transfer Characteristics

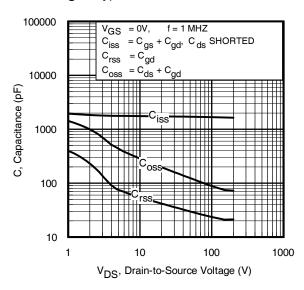


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

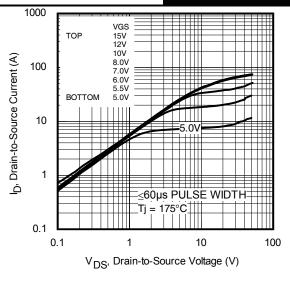


Fig. 2 Typical Output Characteristics

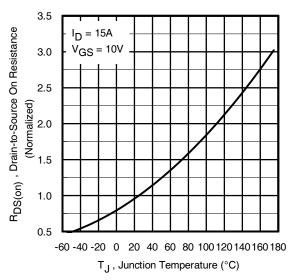


Fig. 4 Normalized On-Resistance vs. Temperature

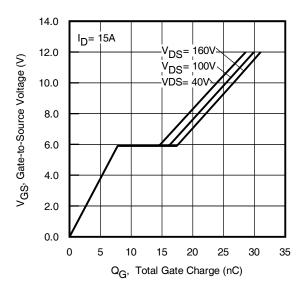
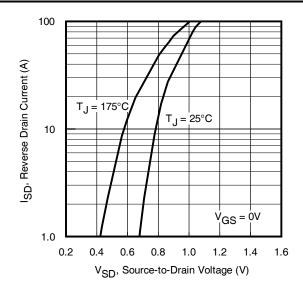
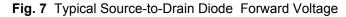


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage







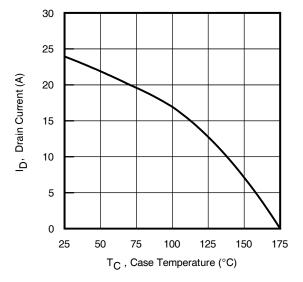


Fig. 9 Maximum Drain Current vs. Case Temperature

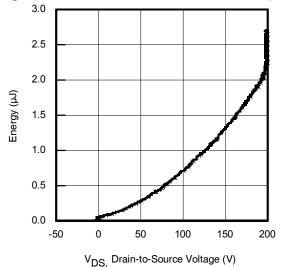


Fig. 11 Typical Coss Stored Energy

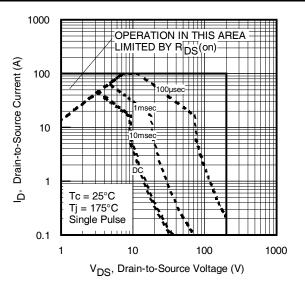
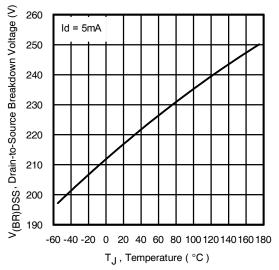


Fig 8. Maximum Safe Operating Area





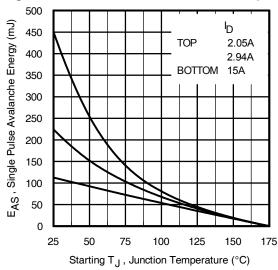
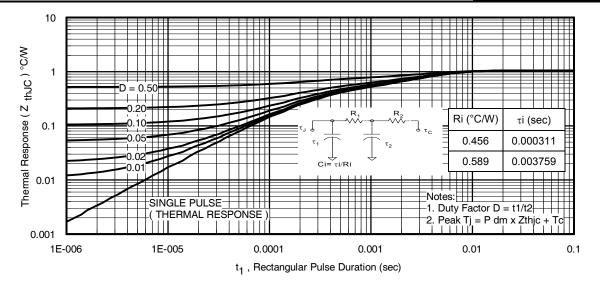


Fig 12. Maximum Avalanche Energy vs. Drain Current







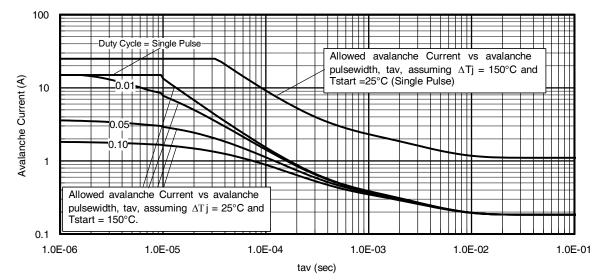


Fig 14. Typical Avalanche Current Vs. Pulse width

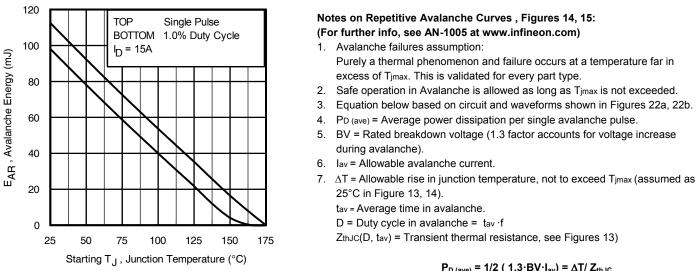
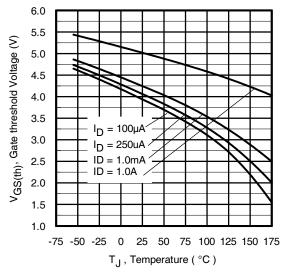


Fig 15. Maximum Avalanche Energy Vs. Temperature

$$\begin{split} P_{D (ave)} &= 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC} \\ I_{av} &= 2\Delta T / [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS (AR)} &= P_{D (ave)} \cdot t_{av} \end{split}$$







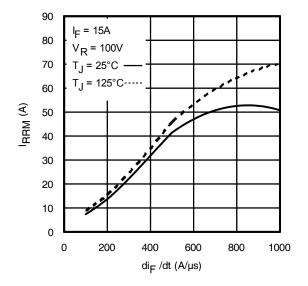


Fig. 18 - Typical Recovery Current vs. dif/dt

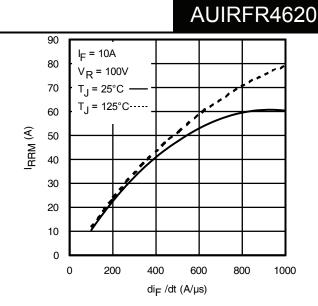


Fig. 17 - Typical Recovery Current vs. dif/dt

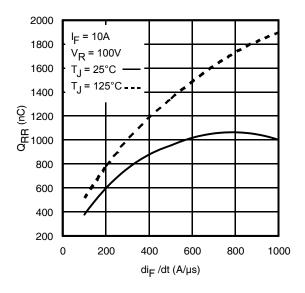


Fig. 19 - Typical Stored Charge vs. dif/dt

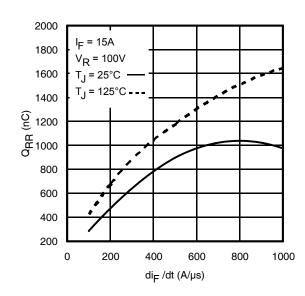


Fig. 20 - Typical Stored Charge vs. dif/dt



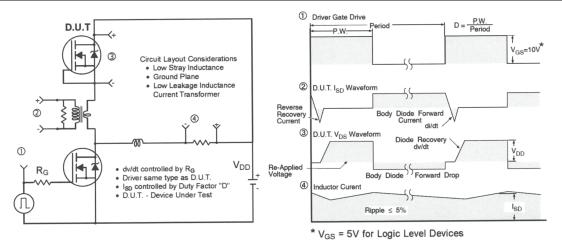


Fig 20. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

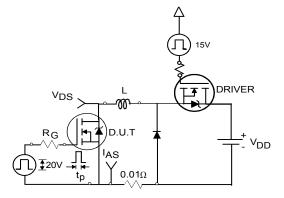


Fig 21a. Unclamped Inductive Test Circuit

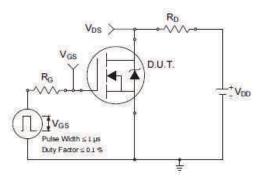


Fig 22a. Switching Time Test Circuit

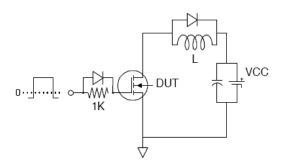


Fig 23a. Gate Charge Test Circuit

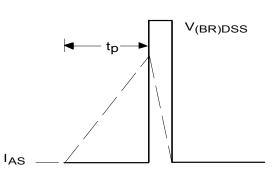


Fig 21b. Unclamped Inductive Waveforms

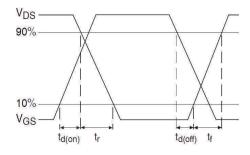


Fig 22b. Switching Time Waveforms

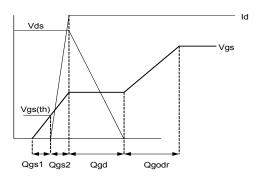
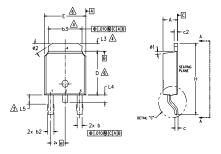


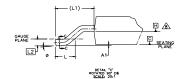
Fig 23b. Gate Charge Waveform

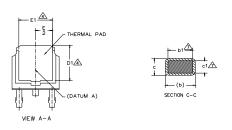


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

9	OUTLINE	CONFORMS	TO	JEDEC	OUTLINE	TO-252AA.	

S Y M		DIMENSIONS						
В	MILLIM	LIMETERS INCHES			0 T			
0 L	MIN.	MAX.	MIN.	MAX.	Ê			
А	2.18	2.39	.086	.094				
A1	-	0.13	-	.005				
b	0.64	0.89	.025	.035				
b1	0.65	0.79	.025	.031	7			
b2	0.76	1.14	.030	.045				
b3	4.95	5.46	.195	.215	4			
с	0.46	0.61	.018	.024				
c1	0.41	0.56	.016	.022	7			
c2	0.46	0.89	.018	.035				
D	5.97	6.22	.235	.245	6			
D1	5.21	-	.205	-	4			
Е	6.35	6.73	.250	.265	6			
E1	4.32	-	.170	-	4			
е	2.29	2.29 BSC		BSC				
н	9.40	10.41	.370	.410				
L	1.40	1.78	.055	.070				
L1	2.74	2.74 BSC .108 REF.		REF.				
L2	0.51	BSC	.020	BSC				
L3	0.89	1.27	.035	.050	4			
L4	-	1.02	-	.040				
L5	1.14	1.52	.045	.060	3			
ø	0.	10 °	0.	10 °				
ø1	0.	15 '	0.	15°				
ø2	25'	35*	25*	35*				

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

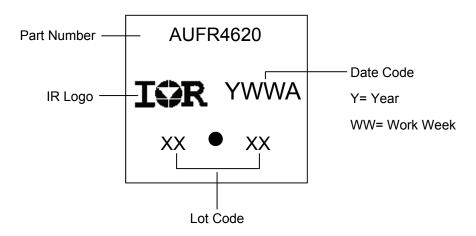
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

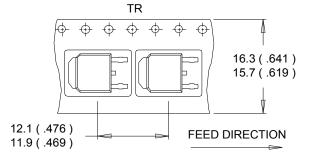
4.- COLLECTOR

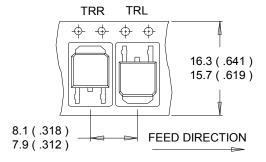
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

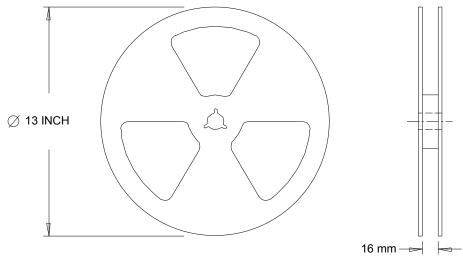
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)			
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture	Sensitivity Level	D-Pak	MSL1		
			Class M3 (+/- 400V) [†]		
	Machine Model	AEC-Q101-002			
		Class H1B (+/- 1000V) [†]			
ESD	Human Body Model	AEC-Q101-001			
			Class C5 (+/- 2000V) [†]		
Charged Device Model		AEC-Q101-005			
RoHS Compliant			Yes		

† Highest passing voltage.

Revision History

Date	Comments
12/1/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Updated typo on the fig.19 and fig.20, unit of y-axis from "A" to "nC" on page 6.

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